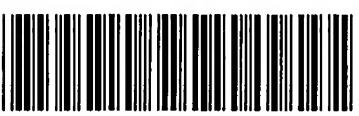


Search Notes	Application/Control No.	Applicant(s)/Patent Under Reexamination
	10570594	TAKATOH ET AL.
	Examiner	Art Unit
	Pande, Suchira	1637

SEARCHED

Class	Subclass	Date	Examiner

SEARCH NOTES

Search Notes	Date	Examiner
STN Structure done by STIC	2007/09/10	SP
PALM Inventor name search	2007/09/10	SP
Science Direct	2007/08/01	SP

INTERFERENCE SEARCH

Class	Subclass	Date	Examiner